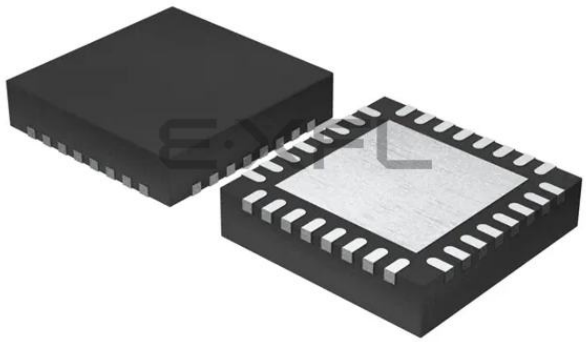

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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	56800EX
Core Size	32-Bit Single-Core
Speed	100MHz
Connectivity	I²C, SCI, SPI
Peripherals	DMA, POR, PWM, WDT
Number of I/O	26
Program Memory Size	64KB (32K x 16)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 16
Voltage - Supply (Vcc/Vdd)	2.7V ~ 3.6V
Data Converters	A/D 6x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount, Wettable Flank
Package / Case	32-VFQFN Exposed Pad
Supplier Device Package	32-HVQFN (5x5)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc56f82743vfm

Table of Contents

1 Overview

1.1 MC56F827xx Product Family

The following table is the comparsion of features among members of the family.

Table 1. MC56F827xx Family

Feature	MC56F82											
Part Number[1]	748V LH	746V LF 746M LF	743V LC	743V FM	738V LH	736V LF	733V LC	733V FM 733M FM	728V LH	726V LF	723V LC	723V FM
Core frequency (MHz)	100/50	100/50	100/50	100/50	100/50	100/50	100/50	100/50	100/50	100/50	100/50	100/50
Flash memory (KB)	64	64	64	64	48	48	48	48	32	32	32	32
RAM (KB)	8	8	8	8	8	8	8	8	6	6	6	6
Interrupt Controller	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
Windowed Computer Operating Properly (WCOP)	1	1	1	1	1	1	1	1	1	1	1	1
External Watchdog Monitor (EWM)	1	1	1	1	1	1	1	1	1	1	1	1
Periodic Interrupt Timer (PIT)	2	2	2	2	2	2	2	2	2	2	2	2
Cyclic Redundancy Check (CRC)	1	1	1	1	1	1	1	1	1	1	1	1
Quad Timer (TMR)	1x4	1x4	1x4	1x4	1x4	1x4	1x4	1x4	1x4	1x4	1x4	1x4
12-bit Cyclic ADC channels	2x8	2x5	2x3	2x3	2x8	2x5	2x3	2x3	2x8	2x5	2x3	2x3
PWM Module:												
Input capture channels[2]	12	6	6	6	12	6	6	6	12	6	6	6
High-resolution channels	8	6	6	6	8	6	6	6	8	6	6	6
Standard channels	4	0	0	0	4	0	0	0	4	0	0	0
12-bit DAC	2	2	2	2	2	2	2	2	2	2	2	2
DMA	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes

Table continues on the next page...

1.6.3 Periodic Interrupt Timer (PIT) Modules

- 16-bit counter with programmable count modulo
- PIT0 is master and PIT1 is slave (if synchronizing both PITs)
- The output signals of both PIT0 and PIT1 are internally connected to a peripheral crossbar module
- Can run when the CPU is in Wait/Stop modes. Can also wake up the CPU from Wait/Stop modes.
- In addition to its existing bus clock (up to 50 MHz), 3 alternate clock sources for the counter clock are available:
  - Crystal oscillator output
  - 8 MHz / 400 kHz ROSC (relaxation oscillator output)
  - On-chip low-power 200 kHz oscillator

1.6.4 Inter-Module Crossbar and AND-OR-INVERT logic

- Provides generalized connections between and among on-chip peripherals: ADCs, 12-bit DAC, comparators, quad-timers, eFlexPWMs, EWM, and select I/O pins
- User-defined input/output pins for all modules connected to the crossbar
- DMA request and interrupt generation from the crossbar
- Write-once protection for all registers
- AND-OR-INVERT function provides a universal Boolean function generator that uses a four-term sum-of-products expression, with each product term containing true or complement values of the four selected inputs (A, B, C, D).

1.6.5 Comparator

- Full rail-to-rail comparison range
- Support for high and low speed modes
- Selectable input source includes external pins and internal DACs
- Programmable output polarity
- 6-bit programmable DAC as a voltage reference per comparator
- Three programmable hysteresis levels
- Selectable interrupt on rising-edge, falling-edge, or toggle of a comparator output

1.6.6 12-bit Digital-to-Analog Converter

- 12-bit resolution
- Powerdown mode

Table 2. Signal descriptions (continued)

Signal Name	64 LQFP	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
						oscillator output to an external crystal or ceramic resonator.
GPIOC2	5	5	3	Input/Output	Input, internal pullup enabled	GPIO Port C2: After reset, the default state is GPIOC2.
(TXD0)				Output		SCI0 transmit data output or transmit/ receive in single wire operation
(XB_OUT11)				Output		Crossbar module output 11
(XB_IN2)				Input		Crossbar module input 2
(CLKO0)				Output		Buffered clock output 0: the clock source is selected by clockout select (CLKOSEL) bits in the clock output select register (CLKOUT) of the SIM.
GPIOC3	7	6	4	Input/Output	Input, internal pullup enabled	GPIO Port C3: After reset, the default state is GPIOC3.
(TA0)				Input/Output		Quad timer module A channel 0 input/ output
(CMPA_O)				Output		Analog comparator A output
(RXD0)				Input		SCI0 receive data input
(CLKIN1)				Input		External clock input 1
GPIOC4	8	7	5	Input/Output	Input, internal pullup enabled	GPIO Port C4: After reset, the default state is GPIOC4.
(TA1)				Input/Output		Quad timer module A channel 1 input/ output
(CMPB_O)				Output		Analog comparator B output
(XB_IN6)				Input		Crossbar module input 6
(EWM_OUT_B)				Output		External Watchdog Module output
GPIOC5	18	13	—	Input/Output	Input, internal pullup enabled	GPIO Port C5: After reset, the default state is GPIOC5.
(DACA_O)				Analog Output		12-bit digital-to-analog output
(XB_IN7)				Input		Crossbar module input 7
GPIOC6	31	23	15	Input/Output	Input, internal pullup enabled	GPIO Port C6: After reset, the default state is GPIOC6.
(TA2)				Input/Output		Quad timer module A channel 2 input/ output
(XB_IN3)				Input		Crossbar module input 3
(CMP_REF)				Analog Input		Positive input 3 of analog comparator A and B and C.
($\overline{\text{SS0\_B}}$)				Input/Output		In slave mode, $\overline{\text{SS0\_B}}$ indicates to the SPI module 0 that the current transfer is to be received.
GPIOC7	32	24	—	Input/Output	Input, internal pullup enable	GPIO Port C7: After reset, the default state is GPIOC7.

Table continues on the next page...

Table 2. Signal descriptions (continued)

Signal Name	64 LQFP	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
GPIOE4	51	39	25	Input/Output	Input, internal pullup enabled	GPIO Port E4: After reset, the default state is GPIOE4.
(PWMA_2B)				Input/Output		PWM module A (NanoEdge), submodule 2, output B or input capture B
(XB_IN2)				Input		Crossbar module input 2
GPIOE5	52	40	26	Input/Output	Input, internal pullup enabled	GPIO Port E5: After reset, the default state is GPIOE5.
(PWMA_2A)				Input/Output		PWM module A (NanoEdge), submodule 2, output A or input capture A
(XB_IN3)				Input		Crossbar module input 3
GPIOE6	53	—	—	Input/Output	Input, internal pullup enabled	GPIO Port E6: After reset, the default state is GPIOE6.
(PWMA_3B)				Input/Output		PWM module A (NanoEdge), submodule 3, output B or input capture B
(XB_IN4)				Input		Crossbar module input 4
GPIOE7	54	—	—	Input/Output	Input, internal pullup enabled	GPIO Port E7: After reset, the default state is GPIOE7.
(PWMA_3A)				Input/Output		PWM module A (NanoEdge), submodule 3, output A or input capture A
(XB_IN5)				Input		Crossbar module input 5
GPIOF0	36	28	—	Input/Output	Input, internal pullup enabled	GPIO Port F0: After reset, the default state is GPIOF0.
(XB_IN6)				Input		Crossbar module input 6
(SCLK1)				Input/Output		SPI1 serial clock — In master mode, SCLK1 pin is an output, clocking slaved listeners. In slave mode, SCLK1 pin is the data clock input 0.
GPIOF1	50	38	—	Input/Output	Input, internal pullup enabled	GPIO Port F1: After reset, the default state is GPIOF1.
(CLKO1)				Output		Buffered clock output 1: the clock source is selected by clockout select (CLKOSEL) bits in the clock output select register (CLKOUT) of the SIM.
(XB_IN7)				Input		Crossbar module input 7
(CMPD_O)				Output		Analog comparator D output
GPIOF2	39	—	19	Input/Output	Input, internal pullup enabled	GPIO Port F2: After reset, the default state is GPIOF2.
(SCL0)				Input/Open-drain Output		I^2C0 serial clock
(XB_OUT6)				Output		Crossbar module output 6
(MISO1)				Input/Output		Master in/slave out for SPI1 —In master mode, MISO1 pin is the data input. In slave mode, MISO1 pin is the data output. The MISO line of a slave device

Table continues on the next page...

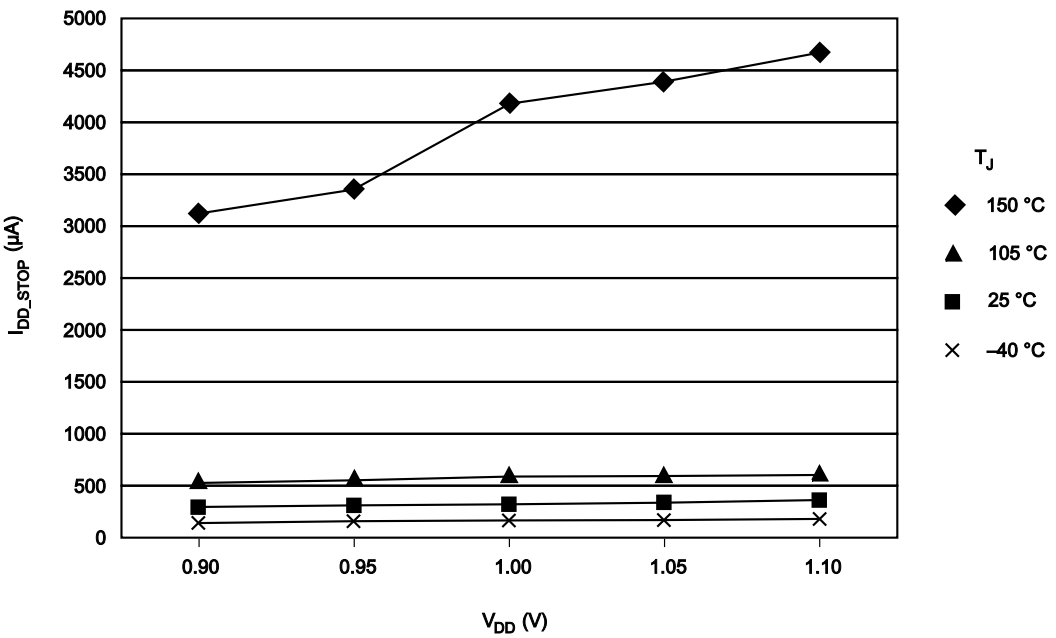
5.8.1 Example 1

This is an example of an operating behavior that includes a typical value:

Symbol	Description	Min.	Typ.	Max.	Unit
I_{WP}	Digital I/O weak pullup/pulldown current	10	70	130	µA

5.8.2 Example 2

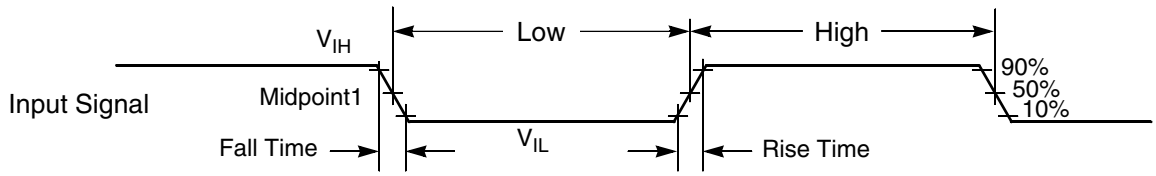
This is an example of a chart that shows typical values for various voltage and temperature conditions:



5.9 Typical value conditions

Typical values assume you meet the following conditions (or other conditions as specified):

Symbol	Description	Value	Unit
T_A	Ambient temperature	25	°C
V_{DD}	3.3 V supply voltage	3.3	V



The midpoint is $V_{IL} + (V_{IH} - V_{IL})/2$.

Figure 3. Input signal measurement references

Figure 4 shows the definitions of the following signal states:

- Active state, when a bus or signal is driven, and enters a low impedance state
- Tri-stated, when a bus or signal is placed in a high impedance state
- Data Valid state, when a signal level has reached V_{OL} or V_{OH}
- Data Invalid state, when a signal level is in transition between V_{OL} and V_{OH}

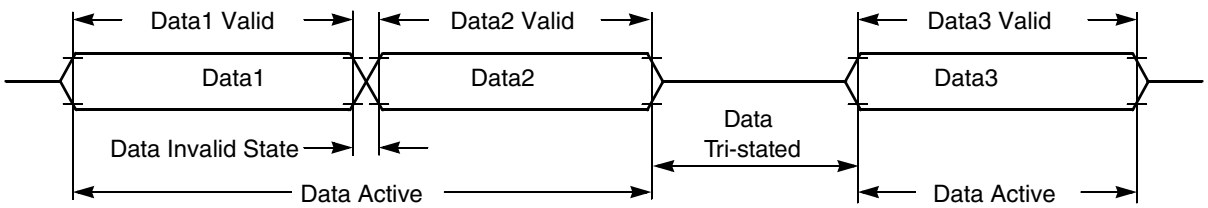


Figure 4. Signal states

7.3 Nonswitching electrical specifications

7.3.1 Voltage and current operating requirements

This section includes information about recommended operating conditions.

NOTE

Recommended V_{DD} ramp rate is between 1 ms and 200 ms.

Table 6. Recommended Operating Conditions (V_{REFLx}=0V, V_{SSA}=0V, V_{SS}=0V)

Characteristic	Symbol	Notes[1]	Min	Typ	Max	Unit
Supply voltage	V_{DD}, V_{DDA}		2.7	3.3	3.6	V
ADC (Cyclic) Reference Voltage High	V_{REFHA} V_{REFHB}		V_{DDA}-0.6		V_{DDA}	V
Voltage difference V_{DD} to V_{DDA}	ΔVDD		-0.1	0	0.1	V
Voltage difference V_{SS} to V_{SSA}	ΔVSS		-0.1	0	0.1	V
Input Voltage High (digital inputs)	V_{IH}	Pin Group 1	0.7 x V_{DD}		5.5	V
$\overline{\text{RESET}}$ Voltage High	V_{IH_RESET}	Pin Group 2	0.7 x V_{DD}	—	V_{DD}	V

Table continues on the next page...

Table 9. Reset, stop, wait, and interrupt timing (continued)

Characteristic	Symbol	Typical Min	Typical Max	Unit	See Figure
$\overline{\text{RESET}}$ deassertion to First Address Fetch	t_{RDA}	865 x T_{OSC} + 8 x T		ns	—
Delay from Interrupt Assertion to Fetch of first instruction (exiting Stop)	t_{IF}	361.3	570.9	ns	—

1. If the $\overline{\text{RESET}}$ pin filter is enabled by setting the RST_FLT bit in the SIM_CTRL register to 1, the minimum pulse assertion must be greater than 21 ns. Recommended a capacitor of up to 0.1 µF on $\overline{\text{RESET}}$.

NOTE

In Table 9, T = system clock cycle and T_{OSC} = oscillator clock cycle. For an operating frequency of 50MHz, T=20 ns. At 4 MHz (used coming out of reset and stop modes), T=250 ns.

Table 10. Power mode transition behavior

Symbol	Description	Min	Max	Unit	Notes[1]
T_{POR}	After a POR event, the amount of delay from when V_{DD} reaches 2.7 V to when the first instruction executes (over the operating temperature range).	199	225	µs	
	STOP mode to RUN mode	6.79	7.27.31	µs	2
	LPS mode to LPRUN mode	240.9	551	µs	3
	VLPS mode to VLPRUN mode	1424	1459	µs	4
	WAIT mode to RUN mode	0.570	0.620	µs	5
	LPWAIT mode to LPRUN mode	237.2	554	µs	3
	VLPWAIT mode to VLPRUN mode	1413	1500	µs	4

1. Wakeup times are measured from GPIO toggle for wakeup till GPIO toggle at the wakeup interrupt subroutine from respective stop/wait mode.
2. Clock configuration: CPU clock=4 MHz. System clock source is 8 MHz IRC in normal mode.
3. CPU clock = 200 KHz and 8 MHz IRC on standby. Exit by an interrupt on PORTC GPIO.
4. Using 64 KHz external clock; CPU Clock = 32KHz. Exit by an interrupt on PortC GPIO.
5. Clock configuration: CPU and system clocks= 100 MHz. Bus Clock = 50 MHz. .Exit by interrupt on PORTC GPIO

7.3.5 Power consumption operating behaviors

Table 11. Current Consumption (mA)

Mode	Maximum Frequency	Conditions	Typical at 3.3 V, 25°C		Maximum at 3.6 V, 105°C		Maximum at 3.6V, 125°C	
			I_{DD}[1]	I_{DDA}	I_{DD}[1]	I_{DDA}	I_{DD}[1]	I_{DDA}
RUN1	100 MHz	• 100 MHz Core • 50 MHz Peripheral clock • Regulators are in full regulation • Relaxation Oscillator on	38.1	9.9	53.5	13.2	53.5	13.2

Table continues on the next page...

Table 11. Current Consumption (mA)

Mode	Maximum Frequency	Conditions	Typical at 3.3 V, 25°C		Maximum at 3.6 V, 105°C		Maximum at 3.6V, 125°C	
			I_{DD}[1]	I_{DDA}	I_{DD}[1]	I_{DDA}	I_{DD}[1]	I_{DDA}
		• All peripheral modules, except COP, disabled and clocks gated off • Processor core in stop mode						

1. No output switching, all ports configured as inputs, all inputs low, no DC loads.
2. In all chip LP modes and flash memory VLP modes, the maximum frequency for flash memory operation is 500 kHz due to the fixed frequency ratio of 1:2 between the CPU clock and the flash clock when running with 2 MHz external clock input and CPU running at 1 MHz.

7.3.6 Designing with radiated emissions in mind

To find application notes that provide guidance on designing your system to minimize interference from radiated emissions:

1. Go to www.freescale.com.
2. Perform a keyword search for "EMC design."

7.3.7 Capacitance attributes

Table 12. Capacitance attributes

Description	Symbol	Min.	Typ.	Max.	Unit
Input capacitance	C_{IN}	—	10	—	pF
Output capacitance	C_{OUT}	—	10	—	pF

7.4 Switching specifications

7.4.1 Device clock specifications

Table 13. Device clock specifications

Symbol	Description	Min.	Max.	Unit	Notes
Normal run mode					
f_{SYSCLK}	Device (system and core) clock frequency • using relaxation oscillator • using external clock source	 0.001 0	 100 100	MHz	
f_{BUS}	Bus clock	—	50	MHz	

7.4.2 General switching timing

Table 14. Switching timing

Symbol	Description	Min	Max	Unit	Notes
	GPIO pin interrupt pulse width[1] Synchronous path	1.5		IP Bus Clock Cycles	
	Port rise and fall time (high drive strength), Slew disabled 2.7 ≤ V_{DD} ≤ 3.6V.	5.5	15.1	ns	
	Port rise and fall time (high drive strength), Slew enabled 2.7 ≤ V_{DD} ≤ 3.6V.	1.5	6.8	ns	2
	Port rise and fall time (low drive strength). Slew disabled . 2.7 ≤ V_{DD} ≤ 3.6V	8.2	17.8	ns	
	Port rise and fall time (low drive strength). Slew enabled . 2.7 ≤ V_{DD} ≤ 3.6V	3.2	9.2	ns	3

1. Applies to a pin only when it is configured as GPIO and configured to cause an interrupt by appropriately programming GPIOn_IPOLR and GPIOn_IENR.
2. 75 pF load
3. 15 pF load

7.5 Thermal specifications

7.5.1 Thermal operating requirements

Table 15. Thermal operating requirements

Symbol	Description		Min	Max	Unit
T_J	Die junction temperature	V	–40	115	°C
		M	–40	135	°C
T_A	Ambient temperature	V	–40	105	°C
		M	–40	125	°C

7.5.2 Thermal attributes

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and voltage regulator circuits, and it is user-determined rather than being controlled by the MCU design. To account for $P_{I/O}$ in power

8.2 System modules

8.2.1 Voltage regulator specifications

The voltage regulator supplies approximately 1.2 V to the MC56F82xxx's core logic. For proper operations, the voltage regulator requires an external 2.2 µF capacitor on each V_{CAP} pin. Ceramic and tantalum capacitors tend to provide better performance tolerances. The output voltage can be measured directly on the V_{CAP} pin. The specifications for this regulator are shown in Table 17.

Table 17. Regulator 1.2 V parameters

Characteristic	Symbol	Min	Typ	Max	Unit
Output Voltage[1]	V_{CAP}	—	1.22	—	V
Short Circuit Current[2]	I_{SS}	—	600	—	mA
Short Circuit Tolerance (V_{CAP} shorted to ground)	T_{RSC}	—	—	30	Minutes

1. Value is after trim
2. Guaranteed by design

Table 18. Bandgap electrical specifications

Characteristic	Symbol	Min	Typ	Max	Unit
Reference Voltage (after trim)	V_{REF}	—	1.21	—	V

8.3 Clock modules

8.3.1 External clock operation timing

Parameters listed are guaranteed by design.

Table 19. External clock operation timing requirements

Characteristic	Symbol	Min	Typ	Max	Unit
Frequency of operation (external clock driver)[1]	f_{osc}	—	—	50	MHz
Clock pulse width[2]	t_{PW}	8			ns
External clock input rise time[3]	t_{rise}	—	—	1	ns
External clock input fall time[4]	t_{fall}	—	—	1	ns
Input high voltage overdrive by an external clock	V_{ih}	$0.85V_{DD}$	—	—	V
Input low voltage overdrive by an external clock	V_{il}	—	—	$0.3V_{DD}$	V

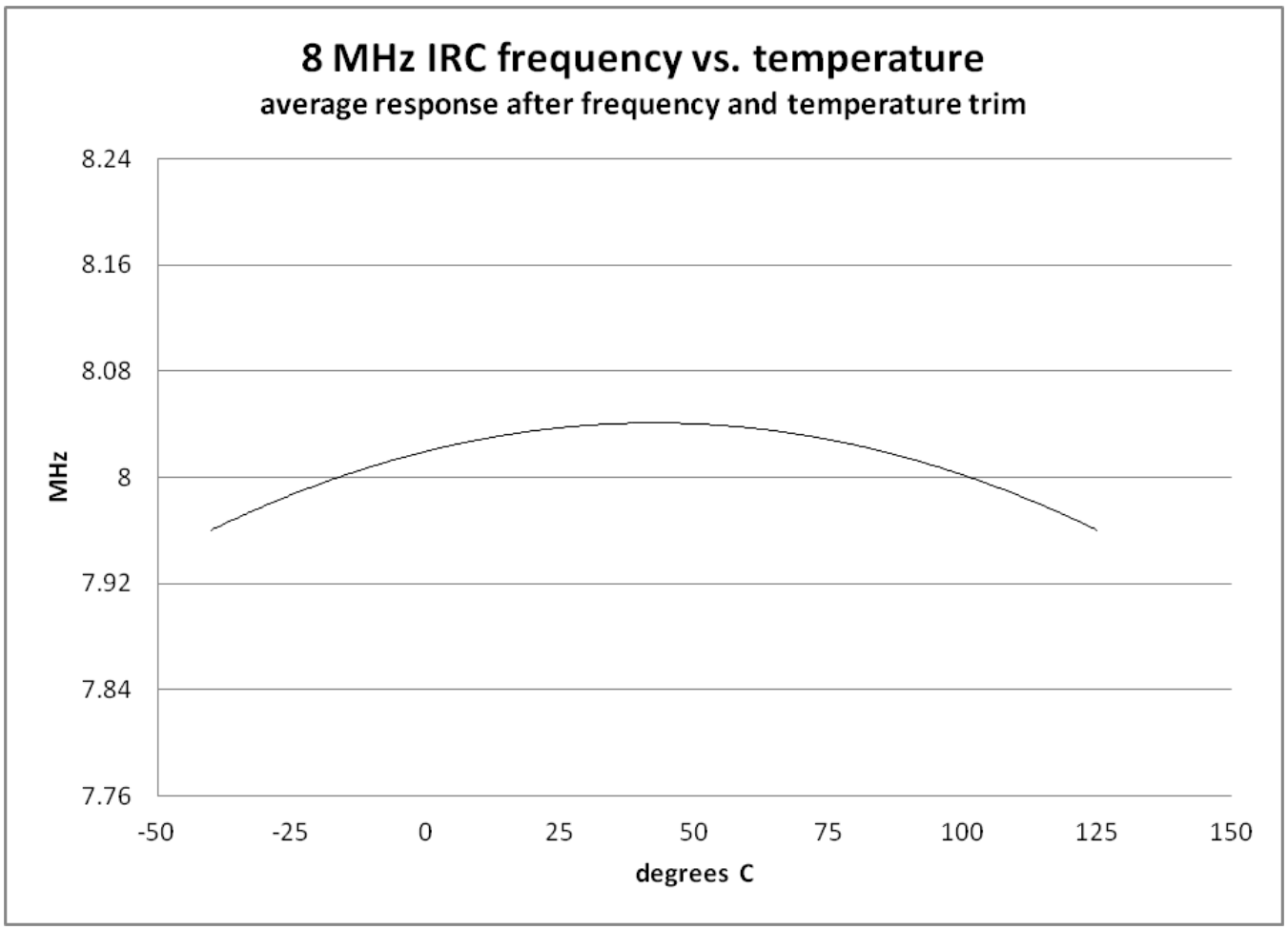


Figure 8. Relaxation Oscillator Temperature Variation (Typical) After Trim (Preliminary)

8.4 Memories and memory interfaces

8.4.1 Flash electrical specifications

This section describes the electrical characteristics of the flash memory module.

8.4.1.1 Flash timing specifications — program and erase

The following specifications represent the amount of time the internal charge pumps are active and do not include command overhead.

Table 23. NVM program/erase timing specifications

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
t_{hvpgm4}	Longword Program high-voltage time	—	7.5	18	µs	—

Table continues on the next page...

Table 23. NVM program/erase timing specifications (continued)

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$t_{hversscr}$	Sector Erase high-voltage time	—	13	113	ms	1
$t_{hversall}$	Erase All high-voltage time	—	52	452	ms	1

1. Maximum time based on expectations at cycling end-of-life.

8.4.1.2 Flash timing specifications — commands

Table 24. Flash command timing specifications

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$t_{rd1sec1k}$	Read 1s Section execution time (flash sector)	—	—	60	µs	1
t_{pgmchk}	Program Check execution time	—	—	45	µs	1
t_{rdrsrc}	Read Resource execution time	—	—	30	µs	1
t_{pgm4}	Program Longword execution time	—	65	145	µs	—
t_{ersscr}	Erase Flash Sector execution time	—	14	114	ms	2
t_{rd1all}	Read 1s All Blocks execution time	—	—	0.9	ms	1
t_{rdonce}	Read Once execution time	—	—	25	µs	1
$t_{pgmonce}$	Program Once execution time	—	65	—	µs	—
t_{ersall}	Erase All Blocks execution time	—	70	575	ms	2
t_{vfykey}	Verify Backdoor Access Key execution time	—	—	30	µs	1

1. Assumes 25 MHz flash clock frequency.
2. Maximum times for erase parameters based on expectations at cycling end-of-life.

8.4.1.3 Flash high voltage current behaviors

Table 25. Flash high voltage current behaviors

Symbol	Description	Min.	Typ.	Max.	Unit
I_{DD_PGM}	Average current adder during high voltage flash programming operation	—	2.5	6.0	mA
I_{DD_ERS}	Average current adder during high voltage flash erase operation	—	1.5	4.0	mA

8.4.1.4 Reliability specifications

Table 26. NVM reliability specifications

Symbol	Description	Min.	Typ.[1]	Max.	Unit	Notes
Program Flash						
$t_{nvmretp10k}$	Data retention after up to 10 K cycles	5	50	—	years	—
$t_{nvmretp1k}$	Data retention after up to 1 K cycles	20	100	—	years	—
$n_{nvmcycp}$	Cycling endurance	10 K	50 K	—	cycles	2

Table 27. 12-bit ADC Electrical Specifications (continued)

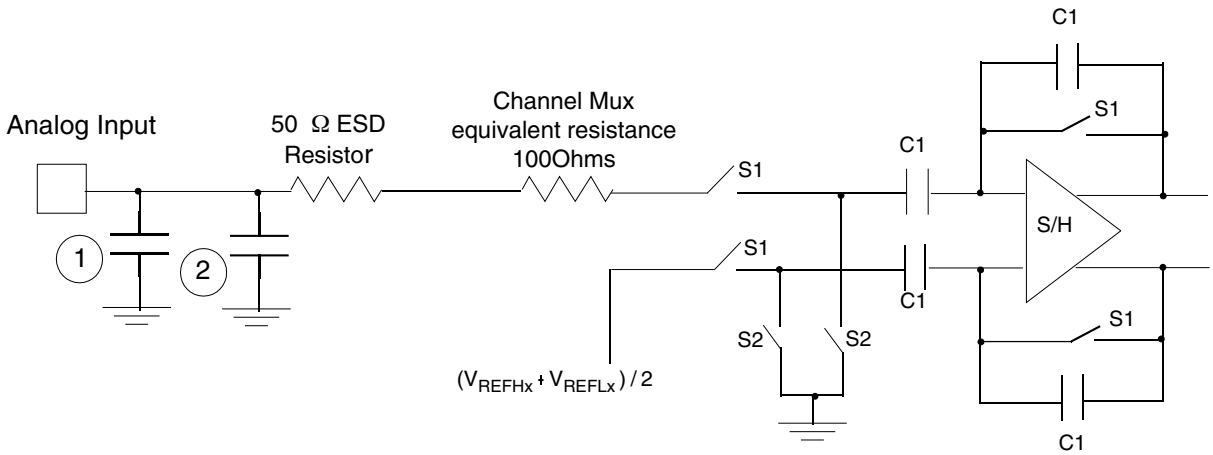
Characteristic	Symbol	Min	Typ	Max	Unit
Spurious Free Dynamic Range	SFDR		77		dB
Signal to Noise plus Distortion	SINAD		66		dB
Effective Number of Bits	ENOB		—		bits
Gain = 1x (Fully Differential/Unipolar)			10.6		
Gain = 2x (Fully Differential/Unipolar)			—		
Gain = 4x (Fully Differential/Unipolar)			10.3		
Gain = 1x (Single Ended)			10.6		
Gain = 2x (Single Ended)			10.4		
Gain = 4x (Single Ended)			10.2		
Variation across channels[10]			0.1		
ADC Inputs					
Input Leakage Current	I_{IN}		1		nA
Temperature sensor slope	T_{SLOPE}		1.7		mV/°C
Temperature sensor voltage at 25 °C	V_{TEMP25}		0.82		V
Disturbance					
Input Injection Current [11]	I_{INJ}			+/-3	mA
Channel to Channel Crosstalk[12]	ISOXTLK		-82		dB
Memory Crosstalk[13]	MEMXTLK		-71		dB
Input Capacitance Sampling Capacitor	C_{ADI}		4.8		pF

1. The ADC functions up to VDDA = 2.7 V. When VDDA is below 3.0 V, ADC specifications are not guaranteed
2. ADC clock duty cycle is 45% ~ 55%
3. Conversion range is defined for x1 gain setting. For x2 and x4 the range is 1/2 and 1/4, respectively.
4. In unipolar mode, positive input must be ensured to be always greater than negative input.
5. First conversion takes 10 clock cycles.
6. INL/DNL is measured from $V_{IN} = V_{REFL}$ to $V_{IN} = V_{REFH}$ using Histogram method at x1 gain setting
7. Least Significant Bit = 0.806 mV at 3.3 V V_{DDA}, x1 gain Setting
8. Offset measured at 2048 code
9. Measured converting a 1 kHz input full scale sine wave
10. When code runs from internal RAM
11. The current that can be injected into or sourced from an unselected ADC input without affecting the performance of the ADC
12. Any off-channel with 50 kHz full-scale input to the channel being sampled with DC input (isolation crosstalk)
13. From a previously sampled channel with 50 kHz full-scale input to the channel being sampled with DC input (memory crosstalk).

8.5.1.1 Equivalent circuit for ADC inputs

The following figure shows the ADC input circuit during sample and hold. S1 and S2 are always opened/closed at non-overlapping phases, and both S1 and S2 are dependent on the ADC clock frequency. The following equation gives equivalent input impedance when the input is selected.

$$\frac{1}{(\text{ADC ClockRate}) \times 4.8 \times 10^{-12}} + 100\ ohm + 50\ ohm$$



1. Parasitic capacitance due to package, pin-to-pin and pin-to-package base coupling = 1.8pF
2. Parasitic capacitance due to the chip bond pad, ESD protection devices and signal routing = 2.04pF
3. S1 and S2 switch phases are non-overlapping and depend on the ADC clock frequency

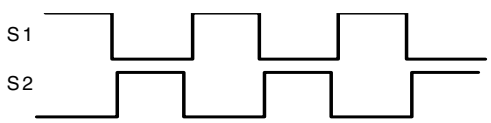


Figure 9. Equivalent circuit for A/D loading

8.5.2 12-bit Digital-to-Analog Converter (DAC) parameters

Table 28. DAC parameters

Parameter	Conditions/Comments	Symbol	Min	Typ	Max	Unit
DC Specifications						
Resolution			12	12	12	bits
Settling time[1]	At output load RLD = 3 kΩ CLD = 400 pF		—	1		µs
Power-up time	Time from release of PWRDWN signal until DACOUT signal is valid	t_{DAPU}	—	—	11	µs
Accuracy						
Integral non-linearity[2]	Range of input digital words:	INL	—	+/- 3	+/- 4	LSB[3]

Table continues on the next page...

Table 32. SPI timing (continued)

Characteristic	Symbol	Min	Max	Unit	See Figure
Clock (SCK) high time	t_{CH}		—	ns	Figure 13
Master			—	ns	Figure 14
Slave					Figure 15
					Figure 16
Clock (SCK) low time	t_{CL}	28	—	ns	Figure 16
Master		28	—	ns	
Slave					
Data set-up time required for inputs	t_{DS}	20	—	ns	Figure 13
Master		1	—	ns	Figure 14
Slave					Figure 15
					Figure 16
Data hold time required for inputs	t_{DH}	1	—	ns	Figure 13
Master		3	—	ns	Figure 14
Slave					Figure 15
					Figure 16
Access time (time to data active from high-impedance state)	t_A	5	—	ns	Figure 16
Slave					
Disable time (hold time to high-impedance state)	t_D	5	—	ns	Figure 16
Slave					
Data valid for outputs	t_{DV}	—		ns	Figure 13
Master		—		ns	Figure 14
Slave (after enable edge)					Figure 15
					Figure 16
Data invalid	t_{DI}	0	—	ns	Figure 13
Master		0	—	ns	Figure 14
Slave					Figure 15
					Figure 16
Rise time	t_R	—	1	ns	Figure 13
Master		—	1	ns	Figure 14
Slave					Figure 15
					Figure 16
Fall time	t_F	—	1	ns	Figure 13
Master		—	1	ns	Figure 14
Slave					Figure 15
					Figure 16

9.2 Electrical design considerations

CAUTION

This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, take normal precautions to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate voltage level.

Use the following list of considerations to assure correct operation of the device:

- Provide a low-impedance path from the board power supply to each V_{DD} pin on the device and from the board ground to each V_{SS} (GND) pin.
- The minimum bypass requirement is to place 0.01–0.1 µF capacitors positioned as near as possible to the package supply pins. The recommended bypass configuration is to place one bypass capacitor on each of the V_{DD}/V_{SS} pairs, including V_{DDA}/V_{SSA}. Ceramic and tantalum capacitors tend to provide better tolerances.
- Ensure that capacitor leads and associated printed circuit traces that connect to the chip V_{DD} and V_{SS} (GND) pins are as short as possible.
- Bypass the V_{DD} and V_{SS} with approximately 100 µF, plus the number of 0.1 µF ceramic capacitors.
- PCB trace lengths should be minimal for high-frequency signals.
- Consider all device loads as well as parasitic capacitance due to PCB traces when calculating capacitance. This is especially critical in systems with higher capacitive loads that could create higher transient currents in the V_{DD} and V_{SS} circuits.
- Take special care to minimize noise levels on the V_{REF}, V_{DDA}, and V_{SSA} pins.
- Using separate power planes for V_{DD} and V_{DDA} and separate ground planes for V_{SS} and V_{SSA} are recommended. Connect the separate analog and digital power and ground planes as near as possible to power supply outputs. If an analog circuit and digital circuit are powered by the same power supply, then connect a small inductor or ferrite bead in serial with V_{DDA}. Traces of V_{SS} and V_{SSA} should be shorted together.
- Physically separate analog components from noisy digital components by ground planes. Do not place an analog trace in parallel with digital traces. Place an analog ground trace around an analog signal trace to isolate it from digital traces.
- Because the flash memory is programmed through the JTAG/EOnCE port, SPI, SCI, or I^2C, the designer should provide an interface to this port if in-circuit flash programming is desired.
- If desired, connect an external RC circuit to the $\overline{\text{RESET}}$ pin. The resistor value should be in the range of 4.7 kΩ–10 kΩ; the capacitor value should be in the range of 0.22 µF–4.7 µF.

11 Pinout

11.1 Signal Multiplexing and Pin Assignments

The following table shows the signals available on each pin and the locations of these pins on the devices supported by this document. The SIM's GPS registers are responsible for selecting which ALT functionality is available on most pins.

NOTE

- The RESETB pin is a 3.3 V pin only.
- If the GPIOC1 pin is used as GPIO, the XOSC should be powered down.
- Not all CMPD pins are not available on 48 LQFP, 32 LQFP, and 32 QFN packages.
- QSPI signals—including MISO1, MOSI1, SCLK1, and SS0_B—are not available on the 48 LQFP, 32 LQFP, and 32 QFN packages.

64 LQFP	48 LQFP	32 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3
1	1	1	TCK	TCK	GPIOD2			
2	2	2	RESETB	RESETB	GPIOD4			
3	3	—	GPIOC0	GPIOC0	EXTAL	CLKIN0		
4	4	—	GPIOC1	GPIOC1	XTAL			
5	5	3	GPIOC2	GPIOC2	TXD0	XB_OUT11	XB_IN2	CLKO0
6	—	—	GPIOF8	GPIOF8	RXD0	XB_OUT10	CMPD_O	PWM_2X
7	6	4	GPIOC3	GPIOC3	TA0	CMPA_O	RXD0	CLKIN1
8	7	5	GPIOC4	GPIOC4	TA1	CMPB_O	XB_IN6	EWM_OUT_B
9	—	—	GPIOA7	GPIOA7	ANA7&CMPD_IN3			
10	—	—	GPIOA6	GPIOA6	ANA6&CMPD_IN2			
11	—	—	GPIOA5	GPIOA5	ANA5&CMPD_IN1			
12	8	—	GPIOA4	GPIOA4	ANA4&CMPD_IN0			
13	9	6	GPIOA0	GPIOA0	ANA0&CMPA_IN3	CMPC_O		
14	10	7	GPIOA1	GPIOA1	ANA1&CMPA_IN0			
15	11	8	GPIOA2	GPIOA2	ANA2&VREFHA&CMPA_IN1			
16	12	—	GPIOA3	GPIOA3	ANA3&VREFLA&CMPA_IN2			
17	—	—	GPIOB7	GPIOB7	ANB7&CMPB_IN2			
18	13	—	GPIOC5	GPIOC5	DACA_O	XB_IN7		
19	—	—	GPIOB6	GPIOB6	ANB6&CMPB_IN1			

64 LQFP	48 LQFP	32 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3
20	—	—	GPIOB5	GPIOB5	ANB5&CMPC_IN2			
21	14	—	GPIOB4	GPIOB4	ANB4&CMPC_IN1			
22	15	9	VDDA	VDDA				
23	16	10	VSSA	VSSA				
24	17	11	GPIOB0	GPIOB0	ANB0&CMPB_IN3			
25	18	12	GPIOB1	GPIOB1	ANB1&CMPB_IN0	DACB_O		
26	19	—	VCAP	VCAP				
27	20	13	GPIOB2	GPIOB2	ANB2&VERFHB&CMPC_IN3			
28	21	—	GPIOB3	GPIOB3	ANB3&VREFLB&CMPC_IN0			
29	—	—	VDD	VDD				
30	22	14	VSS	VSS				
31	23	15	GPIOC6	GPIOC6	TA2	XB_IN3	CMP_REF	SS0_B
32	24	—	GPIOC7	GPIOC7	SS0_B	TXD0	XB_IN8	
33	25	16	GPIOC8	GPIOC8	MISO0	RXD0	XB_IN9	XB_OUT6
34	26	17	GPIOC9	GPIOC9	SCLK0	XB_IN4	TXD0	XB_OUT8
35	27	18	GPIOC10	GPIOC10	MOSI0	XB_IN5	MISO0	XB_OUT9
36	28	—	GPIOF0	GPIOF0	XB_IN6		SCLK1	
37	29	—	GPIOC11	GPIOC11	CANTX	SCL0	TXD1	
38	30	—	GPIOC12	GPIOC12	CANRX	SDA0	RXD1	
39	—	19	GPIOF2	GPIOF2	SCL0	XB_OUT6	MISO1	
40	—	20	GPIOF3	GPIOF3	SDA0	XB_OUT7	MOSI1	
41	—	—	GPIOF4	GPIOF4	TXD1	XB_OUT8	PWM_0X	PWM_FAULT6
42	—	—	GPIOF5	GPIOF5	RXD1	XB_OUT9	PWM_1X	PWM_FAULT7
43	31	—	VSS	VSS				
44	32	—	VDD	VDD				
45	33	21	GPIOE0	GPIOE0	PWM_0B			
46	34	22	GPIOE1	GPIOE1	PWM_0A			
47	35	23	GPIOE2	GPIOE2	PWM_1B			
48	36	24	GPIOE3	GPIOE3	PWM_1A			
49	37	—	GPIOC13	GPIOC13	TA3	XB_IN6	EWM_OUT_B	
50	38	—	GPIOF1	GPIOF1	CLKO1	XB_IN7	CMPD_O	
51	39	25	GPIOE4	GPIOE4	PWM_2B	XB_IN2		
52	40	26	GPIOE5	GPIOE5	PWM_2A	XB_IN3		
53	—	—	GPIOE6	GPIOE6	PWM_3B	XB_IN4		
54	—	—	GPIOE7	GPIOE7	PWM_3A	XB_IN5		
55	41	—	GPIOC14	GPIOC14	SDA0	XB_OUT4	PWM_FAULT4	
56	42	—	GPIOC15	GPIOC15	SCL0	XB_OUT5	PWM_FAULT5	
57	43	27	VCAP	VCAP				
58	—	—	GPIOF6	GPIOF6		PWM_3X		XB_IN2
59	—	—	GPIOF7	GPIOF7		CMPC_O	SS1_B	XB_IN3

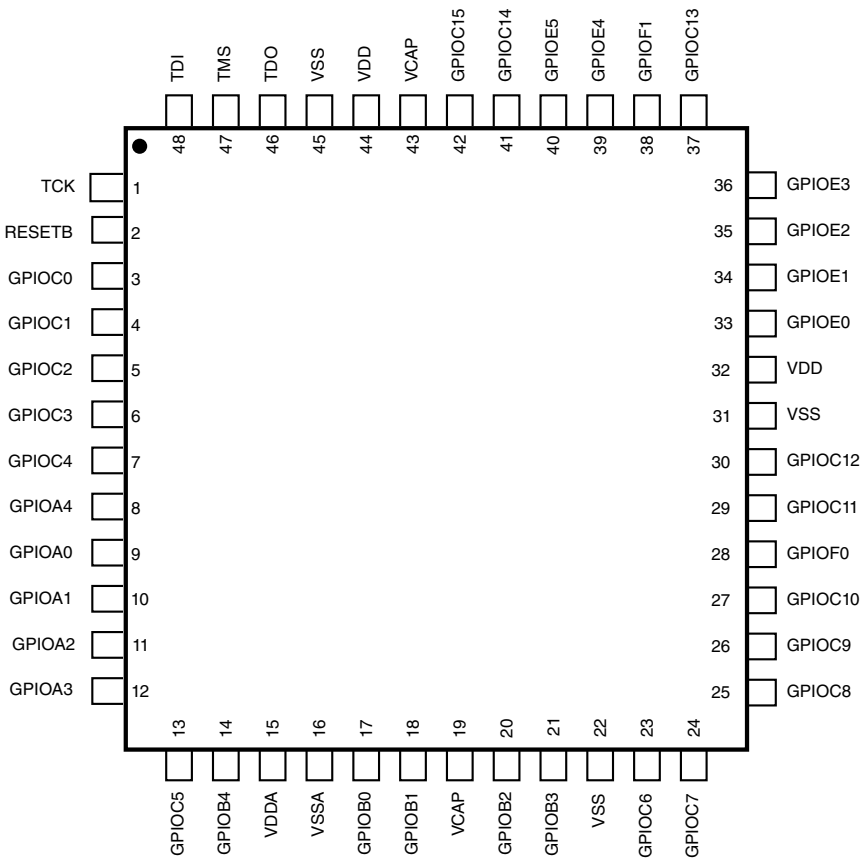


Figure 24. 48-pin LQFP

NOTE

The RESETB pin is a 3.3 V pin only.